
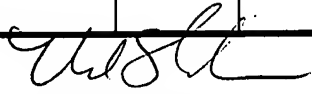



<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/658,814	SURACE ET AL.	
	Examiner	Art Unit	
	Chi Q. Nguyen	3635	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
52		642			52	787.11	309.9	783.1	
INTERNATIONAL CLASSIFICATION									
E	0	4	B	1/32					
				7/08					
				/					
				/					
				/					
Chi Q. Nguyen 11/13/2006 (Assistant Examiner) (Date)					 NAOKO SLACK SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3600 (Primary Examiner) 11/14/06 (Date)			Total Claims Allowed: 18	
 Tonya Nebride 11/22/06 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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